Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/567,629	VADDE ET AL.	
Examiner	Art Unit	

Jason M. Perilla

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SEARCHED						
Class	Subclass	Date	Examiner			
375	295	4/19/2007	JP			
	146	4/19/2007	JP			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

(INCLUDING SEARCH STRATEGY)  DATE EXM				
	DATE	EXMR		
East USPAT/USPGPUB	4/19/2007	JP		
USFAT/USFGFUB				
Inventor Name Search	4/18/2007	JP		
East/EDAN				
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